


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/845,782	HOWELL ET AL.	
	Examiner	Art Unit	
	Hae M. Hyeon	2839	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
385	135	3/05	hmk
385	53	↓	↓

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Update Search Done	3/05	hmk